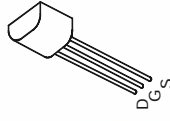


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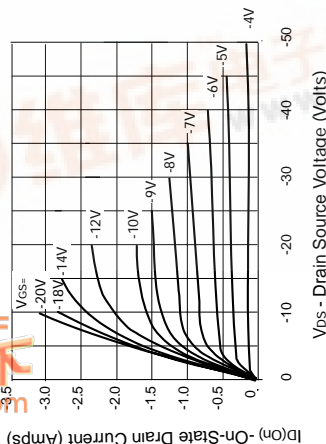
FEATURES

- * 60 Volt V_{DS}
- * $R_{DS(on)}=5\Omega$

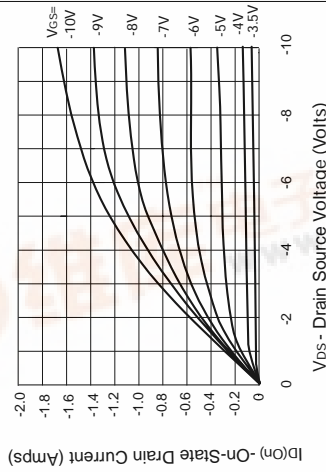


E-Line
TO92 Compatible

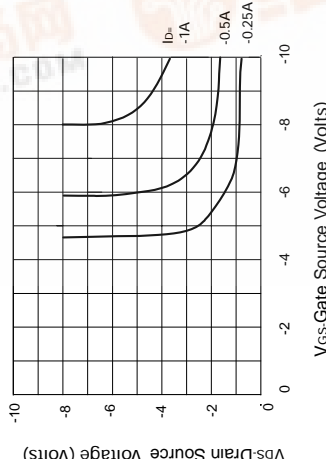
TYPICAL CHARACTERISTICS



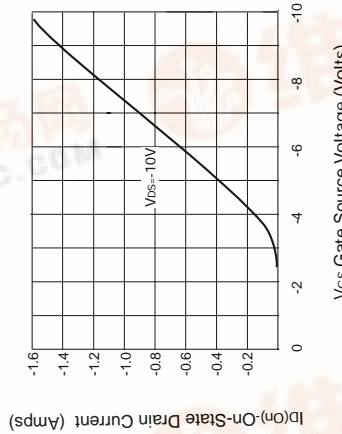
Output Characteristics



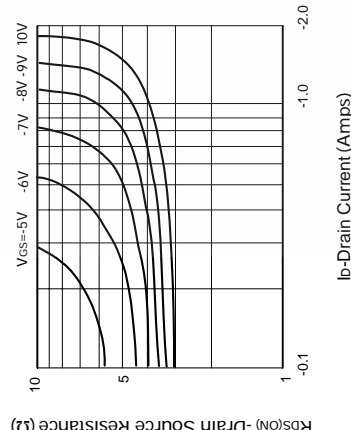
Saturation Characteristics



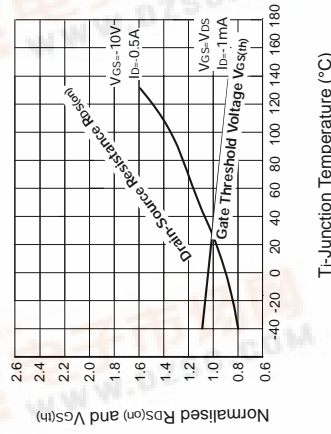
Voltage Saturation Characteristics



Transfer Characteristics



On-resistance v drain current



Normalised $R_{DS(on)}$ and $V_{GS(th)}$ vs Temperature

ABSOLUTE MAXIMUM RATINGS.

PARAMETER	SYMBOL	VALUE	UNIT
Drain-Source Voltage	V_{DS}	-60	V
Continuous Drain Current at $T_{amb}=25^{\circ}C$	I_D	-280	mA
Pulsed Drain Current	I_{DM}	-4	A
Gate Source Voltage	V_{GS}	± 20	V
Power Dissipation at $T_{amb}=25^{\circ}C$	P_{Tot}	700	mW
Operating and Storage Temperature	T_j, T_{stg}	-55 to +150	$^{\circ}C$

ELECTRICAL CHARACTERISTICS (at $T_{amb} = 25^{\circ}C$ unless otherwise stated).

PARAMETER	SYMBOL	MIN.	MAX.	UNIT	CONDITIONS.
Drain-Source Breakdown Voltage	BV_{DSS}	-60		V	$I_D = -1mA, V_{GS} = 0V$
Gate-Source Threshold Voltage	$V_{GS(th)}$	-1.5	-3.5	V	$I_D = -1mA, V_{DS} = V_{GS}$
Gate-Body Leakage	I_{GSS}		20	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
Zero Gate Voltage Drain Current	I_{DSS}	-0.5	-100	μA	$V_{DS} = -60V, V_{GS} = 0V$
On-State Drain Current (1)	$I_{D(on)}$	-1		A	$V_{DS} = -18V, V_{GS} = -10V$
Static Drain-Source On-State Resistance (1)	$R_{DS(on)}$		5	Ω	$V_{GS} = -10V, I_D = -500mA$
Forward Transconductance (1)(2)	g_{fs}		150	mS	$V_{DS} = -18V, I_D = -500mA$
Input Capacitance (2)	C_{iss}		100	pF	
Common Source Output Capacitance (2)	C_{oss}		60	pF	$V_{DS} = -18V, V_{GS} = 0V, f = 1MHz$
Reverse Transfer Capacitance (2)	C_{rss}		20	pF	
Turn-On Delay Time (2)(3)	$t_{d(on)}$		7	ns	
Rise Time (2)(3)	t_r		15	ns	$V_{DD} = -18V, I_D = -500mA$
Turn-Off Delay Time (2)(3)	$t_{d(off)}$		12	ns	
Fall Time (2)(3)	t_f		15	ns	

(1) Measured under pulsed conditions. Width=300 μs . Duty cycle $\leq 2\%$
(2) Sample test.

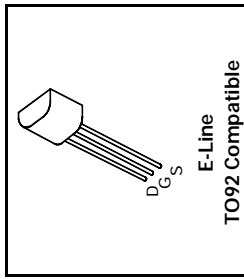
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P-CHANNEL ENHANCEMENT MODE VERTICAL DMOS FET

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FEATURES

- * 60 Volt V_{DS}
- * $R_{DS(on)}=5\Omega$



ABSOLUTE MAXIMUM RATINGS.

PARAMETER	SYMBOL	VALUE	UNIT
Drain-Source Voltage	V_{DS}	-60	V
Continuous Drain Current at $T_{amb}=25^\circ\text{C}$	I_D	-280	mA
Pulsed Drain Current	I_{DM}	-4	A
Gate Source Voltage	V_{GS}	± 20	V
Power Dissipation at $T_{amb}=25^\circ\text{C}$	P_{Tot}	700	mW
Operating and Storage Temperature Range	T_j, T_{stg}	-55 to +150	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS (at $T_{amb} = 25^\circ\text{C}$ unless otherwise stated).

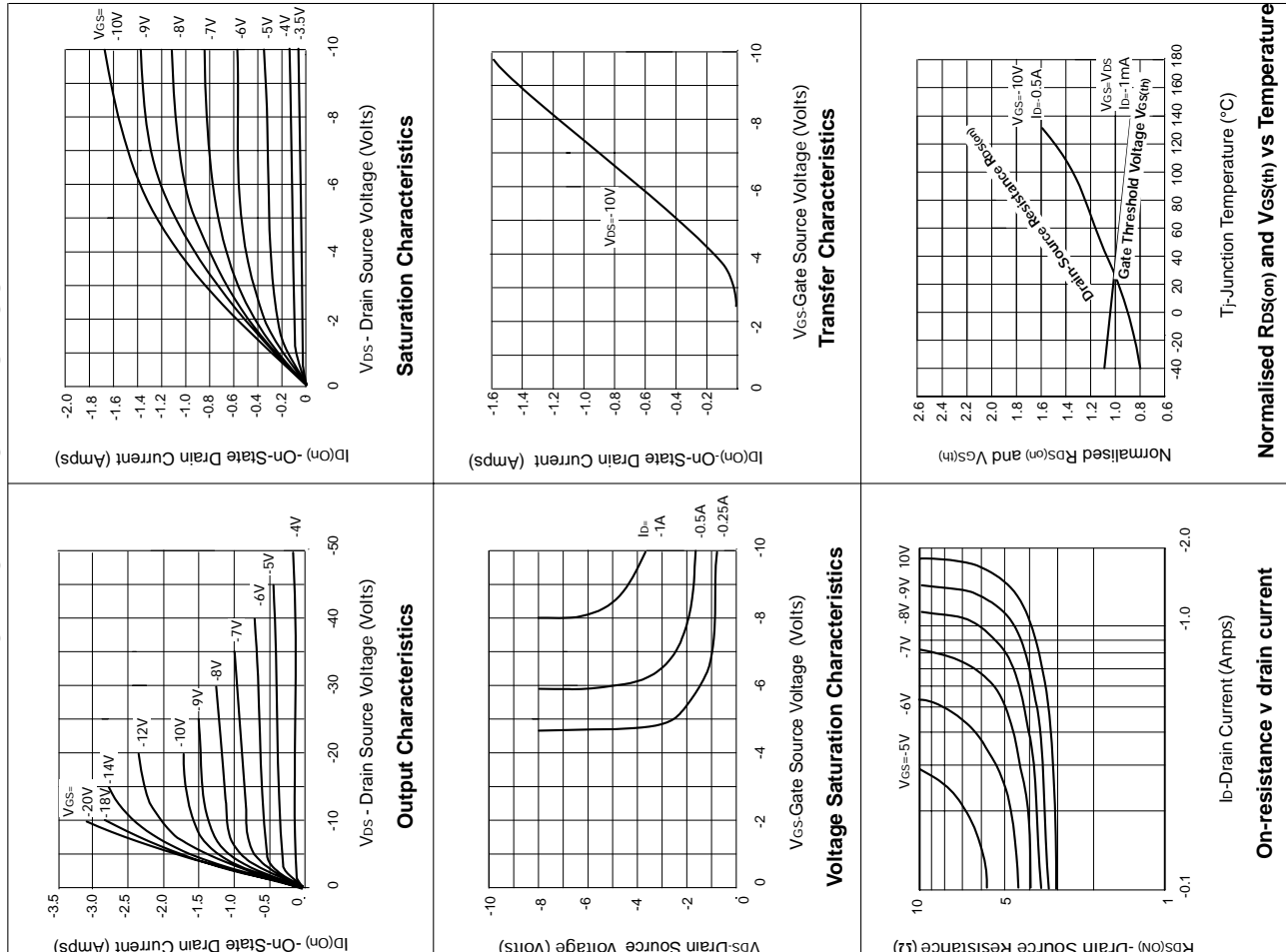
PARAMETER	SYMBOL	MIN.	MAX.	UNIT	CONDITIONS
Drain-Source Breakdown Voltage	BV_{DSS}	-60		V	$I_D=-1\text{mA}, V_{GS}=0\text{V}$
Gate-Source Threshold Voltage	$V_{GS(th)}$	-1.5	-3.5	V	$I_D=-1\text{mA}, V_{DS}=V_{GS}$
Gate-Body Leakage	I_{GSS}		20	nA	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$
Zero Gate Voltage Drain Current	I_{DSS}		-0.5 -100	μA μA	$V_{DS}=-60\text{V}, V_{GS}=0$ $V_{DS}=-48\text{V}, V_{GS}=0\text{V}, T=125^\circ\text{C}(2)$
On-State Drain Current (1)	$I_{D(on)}$	-1		A	$V_{DS}=-18\text{V}, V_{GS}=-10\text{V}$
Static Drain-Source On-State Resistance (1)	$R_{DS(on)}$		5	Ω	$V_{GS}=-10\text{V}, I_D=-500\text{mA}$
Forward Transconductance (1)(2)	g_{fs}	150		mS	$V_{DS}=-18\text{V}, I_D=-500\text{mA}$
Input Capacitance (2)	C_{iss}		100	pF	
Common Source Output Capacitance (2)	C_{oss}		60	pF	$V_{DS}=-18\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$
Reverse Transfer Capacitance (2)	C_{rss}		20	pF	
Turn-On Delay Time (2)(3)	$t_{d(on)}$		7	ns	
Rise Time (2)(3)	t_r		15	ns	$V_{DD}=-18\text{V}, I_D=-500\text{mA}$
Turn-Off Delay Time (2)(3)	$t_{d(off)}$		12	ns	
Fall Time (2)(3)	t_f		15	ns	

(1) Measured under pulsed conditions. Width=300 μs . Duty cycle $\leq 2\%$

(2) Sample test.

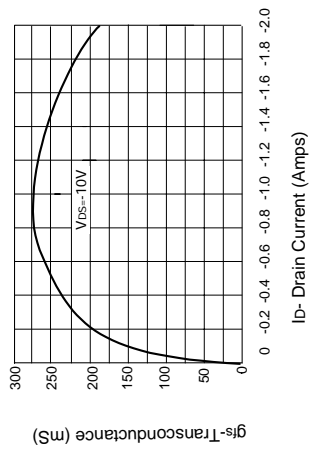
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TYPICAL CHARACTERISTICS

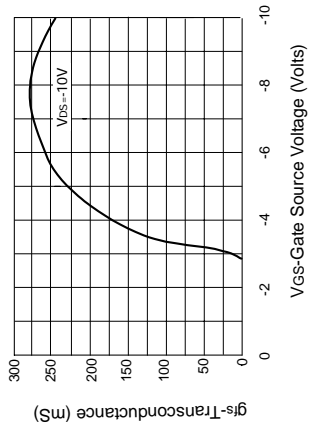


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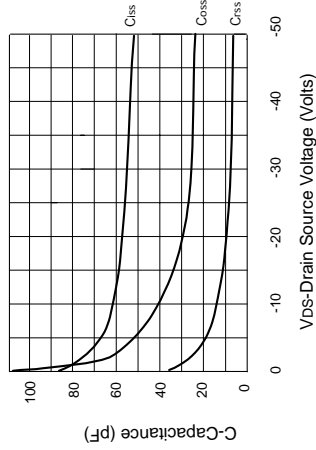
TYPICAL CHARACTERISTICS



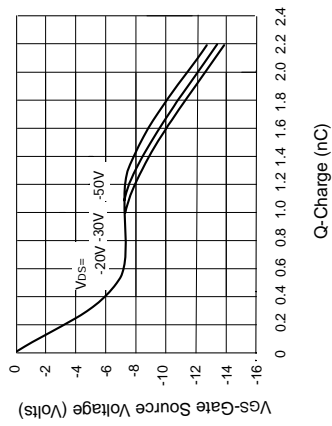
Transconductance v drain current



Transconductance v gate-source voltage



Capacitance v drain-source voltage



Gate charge v gate-source voltage